

**Notice of References Cited**

Application/Control No.

10/656,200

Applicant(s)/Patent Under  
Reexamination  
TOYOFUKU ET AL.

Examiner

DENNIS DICKER

Art Unit

2625

Page 1 of 1

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*	B	US-2003/0070146	04-2003	Sato et al.	715/525
	C	US-			
	D	US-			
	E	US-			
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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